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EMC TEST REPORT For FCC

Test Report No. : CTK02-F170

Date of Issue : February 27, 2003

Model/Type No: : Digimax V3 and Digimax 3500 super

Kind of Product : Digital Camera

Applicant : Samsung Techwin Co.,Ltd.

Applicant Address : #145-3, Sandaewon 1-Dong, Sungnam-Shi, Kyonggi-Do,

Korea

Manufacturer : 1. Samsung Techwin Co.,Ltd.

2. TIANJIN SAMSUNG OPTO-ELECTRONICS Co., Ltd.

Manufacturer Address : 1. #145-3, Sandaewon 1-Dong, Sungnam-Shi, Kyonggi-Do,

Korea

2. No.7, Pingchang Rd, Nankai Dist., Tianjin, P.R.

Contact Person : Mr. G. S. Kim (Manager)

Telephone : +82-31-740-8253

Received Date : December 16, 2002

Test period : Start: February 18, 2003 End: February 25, 2003

Test Results : 🛛 In Compliance 🗆 Not in Compliance

The test results presented in this report relate only to the object tested.

CERTITEK Standards Laboratory Co., Ltd. is accredited by Korea Laboratory Accreditation Scheme (KOLAS) which signed the International Laboratory Accreditation Cooperation (ILAC) Mutual Recognition Arrangement (MRA) for the above test item(s) and test method(s).

Tested by

Joon Pak

EMC Test Engineer

Date: February 27, 2003

Reviewed by

James Hong

EMC Technical Manager

Date: February 27, 2003

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REPORT REVISION HISTORY

Date	Revision	Page No
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1.0 General Product Description

1.0.1 Tested Equipment

Unless otherwise indicated, all tests were conducted on Model Digimax V3 and Digimax 3500 super.

Tests performed on Model Digimax V3 were considered to be representative of Model(s) Digimax 3500 super.

1.0.2 Equipment Size, Mobility and Identification

Dimensions:	105.5 by 54.6 by 38.0	⊠ mm □ in
Mobility:	☐ Hand-Held ☐ Table-top	☐ Floor-standing
-		_
Serial No.:	Not applicable	

1.0.3 Electrical Ratings

Input: Adaptor - AC 100-250V, 50/60Hz

EUT - DC 5.0V

Output: Adaptor – DC 5.0V, 2.0A

EUT - Not applicable

1.0.4 Test Voltage & Frequency (Using the adaptor)

Unless indicated otherwise on the individual data sheet or test results, the test voltage and frequency was as indicated below.

Voltage: AC 120V Frequency: 60Hz

1.0.5 Clock & Other Frequencies Utilized

DSP: 13.5MHz HOST CPU: 5.00MHz TG&CDS&AGC: 45.00MHz

1.1 Model Differences

Digimax V3 and Digimax 3500 super are identical to each other only except for model designation for the marketing purposes.

1.2 Device Modifications

The following modifications were necessary for compliance:

Not applicable

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EUT Configuration(s) 1.3

See Appendix A for individual test set-up configuration(s). The following peripheral devices and/or interface cables were connected during the measurement:

Peripheral Devices

Device	Manufacturer	Model No.	Serial No.	FCC ID or DoC
Adaptor (for EUT)	Ault Korea	PW115KA0500N52	13101005	-
Adaptor (for notebook)	LISHIN INTERNATIONAL	LSE8902A2060	BJJJKJH	-
Notebook PC	I & B COM	Slim 5360	MB0VAA111100094	-
Keyboard (PS/2)	World Com Mart	KB120	-	D840902
Mouse (Serial type)	Microsoft	BASM1	4475951-20000	DoC
CCTV Monitor	KEC	TPM-233-02	-	-

□ Cable Description

#	Description	Ferrited	Length (m)	Other Details
1	AC power cable, Unshielded	No	1.8	Connect to AC power
2	AC power cable, Unshielded	No	1.5	Connect to AC power
3	AC power cable, Unshielded	No	1.5	Connect to AC power
4	DC output cable, Shielded	Yes	1.5	Between the adaptor and EUT
5	DC output cable, Unshielded	Yes	1.5	Between the adaptor and notebook
6	USB cable, Shielded	Yes	1.0	Between the EUT and notebook
7	Keyboard cable, Shielded	No	1.5	PS/2 type
8	Mouse cable, Shielded	No	2.1	Serial type
9	A/V port cable, Unshielded	Yes	1.3	Between the EUT and CCTV notebook

n/a = not available

1.4 **Test Software**

☐ Pinging

1.5 **EUT Operating Mode(s)**

Equipment under test was operated during the measurement under the following conditions: ☐ Test program (H-Pattern) Test program (color bar) Standby ☐ Test program (customer specific) ☑ Practice operation – USB downloading mode AV output monitoring mode (Used to EMI test-data)

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1.6 Calibration Details of Equipment Used for Measurement

Test equipment and test accessories are calibrated on regular basis. The maximum time between calibrations is one year or what is recommended by the manufacturer, whichever is less. All test equipment calibrations are traceable to the Korea Research Institute of Standards and Science (KRISS), therefore, all test data recorded in this report is traceable to KRISS.

1.7 Test Facility

The measurement facility is located at 386-1, Ho-Dong, Yongin-City, Kyungki-Do, Korea 449-100. The sites are constructed in conformance with the requirements of ANSI C63.7, ANSI C63.4 and CISPR Publication 22.

1.8 **Measurement Procedure**

Preliminary AC power line conducted emissions tests were performed shielded room. To find worst mode, several typical mode and typical cable position were tested. Final AC power line conducted emissions test was performed shielded room. (location is same as Preliminary test)

Based on the preliminary tests of the EUT, final test was proceeded worst case test mode and cable configuration.

Preliminary radiated emissions test were performed anechoic chamber (Distance of antenna and EUT was 3 m). To find worst mode, several typical mode and typical cable position were tested and peak level and frequency were recorded.

Final radiated emissions test was performed Open Area Test Site. Based on the preliminary tests of the EUT, final test was proceeded worst case test mode and cable configuration.

* Measurement procedures was In accordance with ANSI C63.4-1992 7.2.3, 7.2.4, 8.3.1.1, 8.3.1.2

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1.9 **Laboratory Accreditations and Listings**

Country	Agency	Scope of Accreditation	Logo
USA	FCC	3 and 10 meter Open Area Test Sites to perform FCC Part 15/18 measurements.	FC 93250
JAPAN	VCCI	10 meter Open Area Test Site and one conducted site.	P-948, C-986
KOREA	MIC	EMI (CE, RE) EMS (ESD, Burst, RS, Surge, CS, Power-Frequency Susceptibility, Voltage Dips and Short Interruptions)	MIC No. 51, KR0025
International	KOLAS	EMC	KOLAS ROLLING NO.118
Europe	GLAS	EMC EN 55011, EN 55022, EN 55024, EN 61326, EN 50130-4, EN 50081-1, EN 50081-2, EN 50082-1, EN 50082-2, EN 61000-6-2, EN 61000-4-2, EN 61000-4-3, EN 61000-4-4, EN 61000-4-5, EN 61000-4-6, EN 61000-4-8, EN 61000-4-11, EN 61000-3-2, EN 61000-3-3	TÜV No.13000796-02

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Emissions Test Regulations 2.0

The emissions tests were performed according to following regulations:							
☐ EN 50081-1:1992							
☐ EN 55011:1998 +A1:1999	☐ Group 1 ☐ Class A	☐ Group 2 ☐ Class B					
☐ EN 55013:1990 +A12:1994 +A13:1996 +A1☐ EN 55013:2001	4: 1999						
☐ EN 55014-1:1993 +A1:1997 +A2:1999	☐ Household appliance☐ Portable tools☐ Semiconductor dev						
☐ EN 55014-1:2000 ☐ EN 55014-2:1997							
☐ EN 55015:1996 +A1:1997 +A2:1999 ☐ EN 55015:2000							
☐ EN 55020:1994 +A11:1996 +A13:1999 +A1☐ EN 55020:1994 +A11:1996 +A12:1999 +A1							
☐ EN 55022:1994 +A1:1995 +A2:1997 ☐ EN 55022:1998 +A1:2000	☐ Class A ☐ Class A	☐ Class B ☐ Class B					
☐ EN 61000-3-2:1995 +A1:1998 +A2:1998 ☐ EN 61000-3-2:1995 +A1:1998 +A2:1998 +A2:198	A14: 2000						
☐ VCCI V-3/99.05 : 1999	☐ Class A	☐ Class B					
☐ FCC Part 15 SUBPART B	☐ Class A	⊠ Class B					
☐ AS 3548 (1992)	☐ Class A	☐ Class B					
☐ CISPR 22 (1997)	☐ Class A	⊠ Class B					

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2.1 Conducted Voltage Emissions

Test Date February 18, 2003 **Test Location** EMI-CE: Shielded Room Test Instruments Rohde & Schwarz ESHS30 828144/002 **Test Accessories** \square LISN **EMCO** 3825/2 9206-1971 **EMCO** 3825/2 9409-2246 3825/2 9607-2574 **EMCO** ☑ Control PC HP Vectra 500 SG72000192 **Frequency Range of Measurement** ☐ 450 kHz to 30 MHz Instrument Settings IF Band Width: 9 kHz **Test Results** The requirements are: minimum margin is 8.6 dBuV at 0.27 MHz

limit exceeded by maximum of ____ dBuV at ____ MHz

Remarks

NOT MET

☐ NOT APPLICABLE

See Appendix A for test data.

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2.2 **Radiated Electric Field Emissions**

Test Date February 18, 2003									
Test Location ☑ EMI-OATS: Testing was performed at a test distance of 10 m ☐ EMI-OATS: Testing was performed at a test distance of 3 m									
Test Instruments ☑ Field Strength Meter		Rohde & Schwarz	ESVS30	826638/008					
		Schwarzbeck EMCO	HL562 BBA9106 3110B 3146	41-00201					
Frequency Range of 30 MHz to 1 GHz	Frequency Range of Measurement 30 MHz to 1 GHz								
Instrument Settings IF Band Width: 120 kHz	i								
Test Results The requirements are:									
		m margin is 3.56 dB (uV ceeded by maximum of	•						

Remarks

See Appendix A for test data

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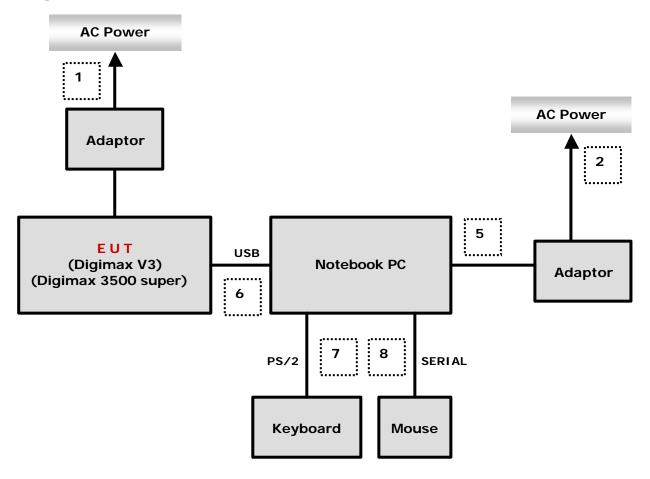
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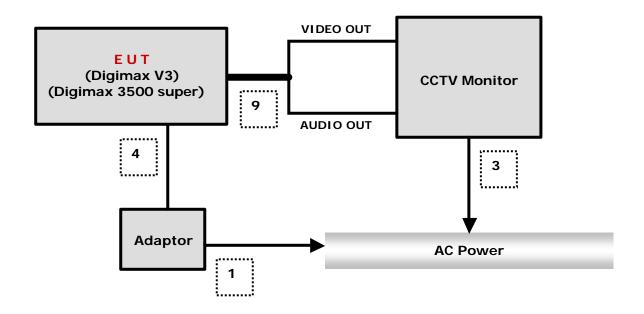


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Configuration





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APPENDIX A - TEST DATA

Conducted Voltage Emissions (Quasi-Peak reading)

Frequency	Corre	Correction		Quasi-peak				Ave	rage		
	Fac	tor	Line	Limit	Reading	Result	Margin	Limit	Reading	Result	Margin
[MHz]	LISN	Cable		[dBuV]	[dBuV]	[dBuV]	[dB]	[dBuV]	[dBuV]	[dBuV]	[dB]
0.15	2.2	0.1	Н	66.0	46.6	48.9	17.1	56.0	5.3	7.6	48.4
0.20	1.7	0.1	N	63.6	50.9	52.7	10.9	53.6	39.1	40.9	12.7
0.26	0.8	0.1	N	61.4	48.7	49.6	11.8	51.4	37.0	37.9	13.5
0.27	0.8	0.1	N	61.1	51.6	52.5	8.6	51.1	36.0	36.9	14.2
0.33	0.7	0.1	Н	59.5	45.1	45.9	13.6	49.5	40.0	40.8	8.7
0.40	0.6	0.1	Н	57.9	43.6	44.3	13.6	47.9	38.2	38.9	9.0
0.60	0.5	0.1	N	56.0	40.8	41.4	14.6	46.0	31.5	32.1	13.9
1.53	0.3	0.1	N	56.0	40.0	40.4	15.6	46.0	29.4	29.8	16.2
1.60	0.3	0.1	N	56.0	40.5	40.9	15.1	46.0	28.8	29.2	16.8
1.66	0.3	0.1	Н	56.0	39.8	40.2	15.8	46.0	35.0	35.4	10.6
1.80	0.3	0.1	N	56.0	40.5	40.9	15.1	46.0	25.4	25.8	20.2
2.33	0.3	0.1	N	56.0	40.3	40.7	15.3	46.0	28.4	28.8	17.2
5.26	0.3	0.1	Н	60.0	38.2	38.6	21.4	50.0	33.1	33.5	16.5
5.33	0.3	0.1	Н	60.0	39.0	39.4	20.6	50.0	33.8	34.2	15.8
5.39	0.3	0.1	Н	60.0	38.4	38.8	21.2	50.0	33.9	34.3	15.7
5.46	0.3	0.1	Н	60.0	37.8	38.2	21.8	50.0	32.9	33.3	16.7
5.53	0.3	0.1	Н	60.0	37.8	38.2	21.8	50.0	32.4	32.8	17.2
5.80	0.3	0.1	N	60.0	44.6	45.0	15.0	50.0	27.9	28.3	21.7

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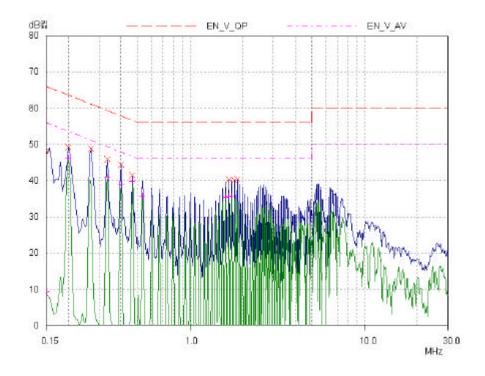
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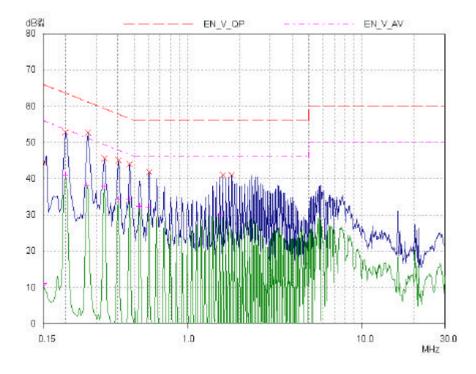
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Radiated Electric Field Emissions (Quasi-Peak reading)

Frequency	Reading	Pol.	Height	Correction Factor		Limits	Result	Margin
[MHz]	[dBuV/m]		[m]	Antenna	Cable	[dBuV/m]	[dBuV/m]	[dB]
78.63	8.8	V	1.0	8.10	1.70	30.0	18.64	11.36
101.64	7.0	V	1.0	9.35	1.90	30.0	18.23	11.77
135.38	8.4	V	1.0	8.40	2.30	30.0	19.13	10.87
202.84	8.4	Н	4.0	7.35	2.80	30.0	18.53	11.47
213.61	7.5	Н	4.0	7.80	2.90	30.0	18.16	11.84
216.35	7.7	Н	4.0	7.95	2.90	30.0	18.53	11.47
473.32	14.0	Н	3.2	15.00	4.40	37.0	33.44	3.56
648.31	8.6	Н	3.7	17.80	5.50	37.0	31.89	5.11
756.84	7.2	Н	3.8	19.00	6.10	37.0	32.32	4.68
811.00	6.9	Н	3.0	19.60	6.60	37.0	33.08	3.92
919.57	3.1	V	2.2	20.80	6.70	37.0	30.64	6.36
972.00	4.9	Н	3.5	21.10	7.00	37.0	33.01	3.99

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